TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

TC74HC564AP,TC74HC564AF TC74HC574AP,TC74HC574AF,TC74HC574AFW

Octal D-Type Filp-Flop with 3-State Output
TC74HC564AP/AF Inverting
TC74HC574AP/AF/AFW Non-Inverting

The TC74HC564A and HC574A are high speed CMOS OCTAL FLIP-FLOPs with 3-STATE OUTPUT fabricated with silicon gate C^2MOS technology.

They achieve the high speed operation similar to equivalent LSTTL while maintaining the CMOS low power dissipation.

These 8-bit D-type flip-flops are controlled by a clock input (CK) and an output enable input (\overline{OE}).

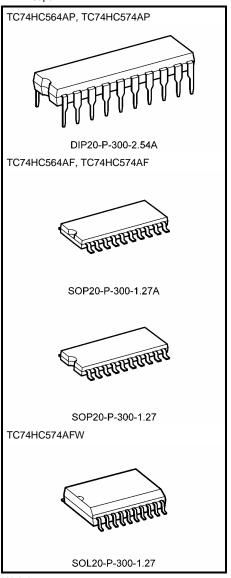
The TC74HC564A has inverting outputs, and the TC74HC574A has non-inverting outputs.

All inputs are equipped with protection circuits against static discharge or transient excess voltage.

Features

- High speed: $f_{max} = 62 \text{ MHz}$ (typ.) at $V_{CC} = 5 \text{ V}$
- Low power dissipation: $I_{CC} = 4 \mu A \text{ (max)}$ at $T_a = 25 \text{°C}$
- High noise immunity: V_{NIH} = V_{NIL} = 28% V_{CC} (min)
- Output drive capability: 15 LSTTL loads
- Symmetrical output impedance: |IOH| = IOL = 6 mA (min)
- Balanced propagation delays: $t_pLH \simeq t_pHL$
- Wide operating voltage range: VCC (opr) = 2 to 6 V
- Pin and function compatible with 74LS564/574

Note: xxxFW (JEDEC SOP) is not available in Japan.



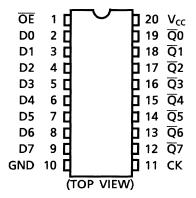
Weight

DIP20-P-300-2.54A : 1.30 g (typ.) SOP20-P-300-1.27A : 0.22 g (typ.) SOP20-P-300-1.27 : 0.22 g (typ.) SOL20-P-300-1.27 : 0.46 g (typ.)

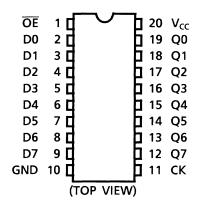


Pin Assignment

TC74HC564A

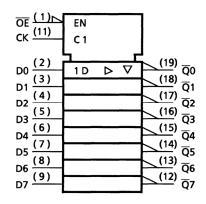


TC74HC574A

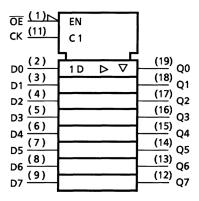


IEC Logic Symbol

TC74HC564A



TC74HC574A



Truth Table

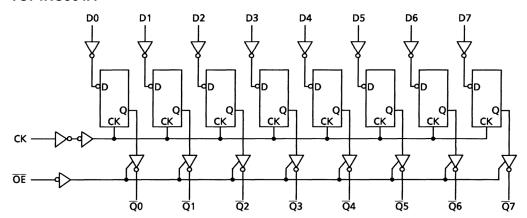
Inputs			Outputs				
ŌĒ	CK	D	Q (574A)	Q (564A)			
Н	Х	Х	Z	Z			
L	\neg	Х	Qn	$\overline{\overline{Q}}_n$			
L		L	L	Н			
L		Н	Н	L			

- X: Don't care
- Z: High impedance
- $Q_n(\overline{Q}_n)$: No change

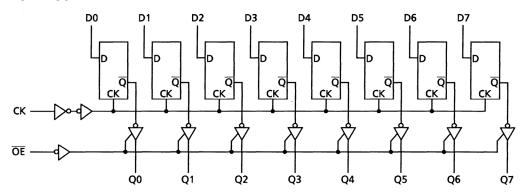


System Diagram

TC74HC564A



TC74HC574A



Absolute Maximum Ratings (Note 1)

Characteristics	Symbol	Rating	Unit
Supply voltage range	V _{CC}	-0.5 to 7	V
DC input voltage	V _{IN}	−0.5 to V _{CC} + 0.5	V
DC output voltage	Vout	-0.5 to V _{CC} + 0.5	V
Input diode current	lık	±20	mA
Output diode current	lok	±20	mA
DC output current	lout	±35	mA
DC V _{CC} /ground current	Icc	±75	mA
Power dissipation	P _D	500 (DIP) (Note 2)/180 (SOP)	mW
Storage temperature	T _{stg}	−65 to 150	°C

Note 1: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Note 2: 500 mW in the range of Ta = -40 to 65°C. From Ta = 65 to 85°C a derating factor of -10 mW/°C shall be applied until 300 mW.



Recommended Operating Conditions (Note)

Characteristics	Symbol	Rating	Unit
Supply voltage	V _{CC}	2 to 6	V
Input voltage	V _{IN}	0 to V _{CC}	V
Output voltage	V _{OUT}	0 to V _{CC}	V
Operating temperature	T _{opr}	-40 to 85	°C
		0 to 1000 (V _{CC} = 2.0 V)	
Input rise and fall time	t _r , t _f	0 to 500 (V _{CC} = 4.5 V)	ns
		0 to 400 ($V_{CC} = 6.0 \text{ V}$)	

Note: The recommended operating conditions are required to ensure the normal operation of the device.
Unused inputs must be tied to either VCC or GND.

Electrical Characteristics

DC Characteristics

Characteristics	Symbol	Test Condition $V_{CC}\left(V\right)$		Ta = 25°C			Ta = -40 to 85°C		Unit	
				V _{CC} (V)	Min	Тур.	Max	Min	Max	
		_		2.0	1.50	_	_	1.50	_	
High-level input voltage	V_{IH}			4.5	3.15		_	3.15	_	V
ŭ				6.0	4.20	_	_	4.20	_	
				2.0	_	_	0.50	_	0.50	
Low-level input voltage	V_{IL}	_		4.5	_		1.35		1.35	V
ŭ				6.0			1.80	—	1.80	
				2.0	1.9	2.0	_	1.9	_	
	Voн	VIN = VIH or VIL	$I_{OH} = -20 \ \mu A$	4.5	4.4	4.5	_	4.4	_	
High-level output voltage				6.0	5.9	6.0	_	5.9	_	V
Ŭ			$I_{OH} = -6 \text{ mA}$	4.5	4.18	4.31	_	4.13	_	
			$I_{OH} = -7.8 \text{ mA}$	6.0	5.68	5.80	_	5.63	_	
	VoL	V _{IN} = V _{IH} or V _{IL}		2.0	_	0.0	0.1	_	0.1	
			$I_{OL} = 20 \mu A$	4.5	_	0.0	0.1	_	0.1	
Low-level output voltage				6.0	_	0.0	0.1	_	0.1	V
Ŭ			I _{OL} = 6 mA	4.5	_	0.17	0.26	_	0.33	
			$I_{OL} = 7.8 \text{ mA}$	6.0		0.18	0.26	—	0.33	
3-state output off-state current	I _{OZ}	$V_{IN} = V_{IH} \text{ or } V_{IL}$ $V_{OUT} = V_{CC} \text{ or GND}$		6.0	_	_	±0.5	_	±5.0	μА
Input leakage current	I _{IN}	V _{IN} = V _{CC} or GND		6.0	_	_	±0.1	_	±1.0	μА
Quiescent supply current	I _{CC}	$V_{IN} = V_{CC}$ or	V _{IN} = V _{CC} or GND		_	_	4.0	_	40.0	μА



Timing Requirements (input: $t_r = t_f = 6$ ns)

Characteristics	Symbol	Test Condition		Ta =	25°C	Ta = -40 to 85°C	Unit	
			V _{CC} (V)	Тур.	Limit	Limit		
Minimum pulse width	4		2.0	_	75	95	ns	
(CK)	t _{W (H)}	_	4.5	_	15	19		
(CK)	t _{W (L)}		6.0	_	13	16		
Minimum act un time	t _s		2.0	_	75	95	ns	
Minimum set-up time (Dn)		_	4.5	_	15	19		
(DII)			6.0	_	13	16		
Minimum hold time			2.0	_	0	0		
(Dn)	t _h	_	4.5	_	0	0	ns	
			6.0	_	0	0		
	f		2.0	_	6	5		
Clock frequency		_	4.5	_	31	24	MHz	
			6.0	_	36	28		



AC Characteristics (input: $t_r = t_f = 6$ ns)

Characteristics	Symbol	Test Condition		Ta = 25°C			Ta = -40 to 85°C		Unit	
	- ,		CL (pF)	V _{CC} (V)	Min	Тур.	Max	Min	Max	
	t _{TLH}			2.0	_	25	60	_	75	
Output transition time		_	50	4.5	_	7	12	_	15	ns
	^t THL			6.0	_	6	10	_	13	
				2.0	_	70	150	_	190	
			50	4.5	_	20	30		38	
Propagation delay time	t _{pLH}			6.0	_	15	26	_	33	ns
(CK-Q, \overline{Q})	t _{pHL}	_		2.0	_	88	190	_	240	115
(= ==, == ,			150	4.5	_	25	38	_	48	
				6.0	_	19	33	_	41	
	[†] pZL [†] pZH	$R_L = 1 \text{ k}\Omega$	50	2.0	_	48	125	_	155	- ns
				4.5	_	15	25	_	31	
Output enable time				6.0	_	12	21	_	26	
Output enable time			150	2.0	_	60	165	_	205	
				4.5	_	20	33	_	41	
				6.0	_	16	28	_	35	
	,			2.0	_	34	125	_	155	
Output disable time	t _{pLZ}	$R_L = 1 \text{ k}\Omega$	50	4.5	_	17	25	_	31	ns
	t _{pHZ}			6.0	_	15	21	_	26	
				2.0	6	17	_	5	_	
Maximum clock frequency	f _{max}	_	50	4.5	31	50	_	24	_	MHz
requeriey				6.0	36	59	_	28		
Input capacitance	C _{IN}	_				5	10	_	10	pF
Output capacitance	C _{OUT}	_	-			10		_	_	pF
Power dissipation capacitance	C _{PD} (Note)	_	_		_	54		_	_	pF

Note: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

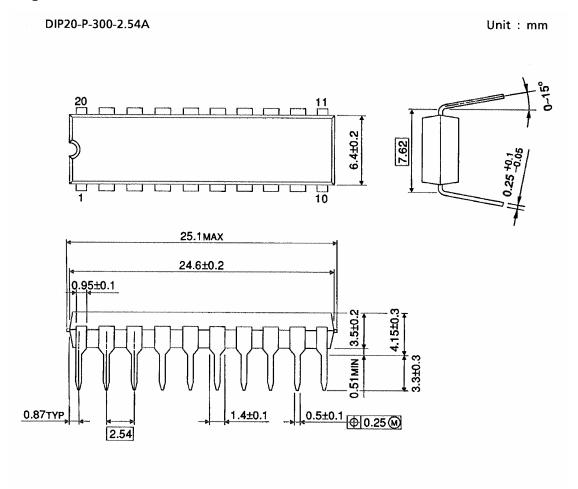
$$I_{CC}$$
 (opr) = $C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/8$ (per bit)

And the total CPD when n pcs. of flip flop operate can be gained by the following equation:

$$C_{PD}$$
 (total) = 39 + 15·n

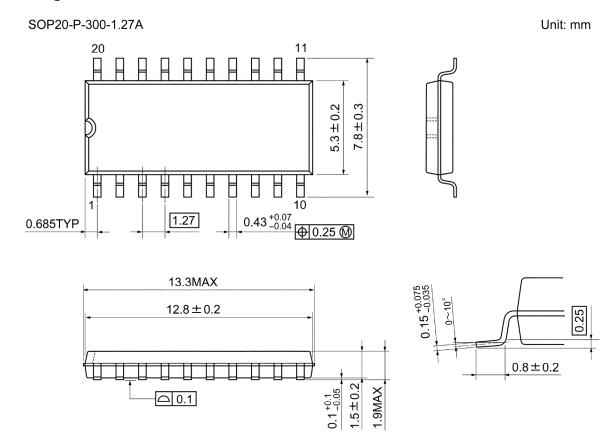


Package Dimensions



Weight: 1.30 g (typ.)

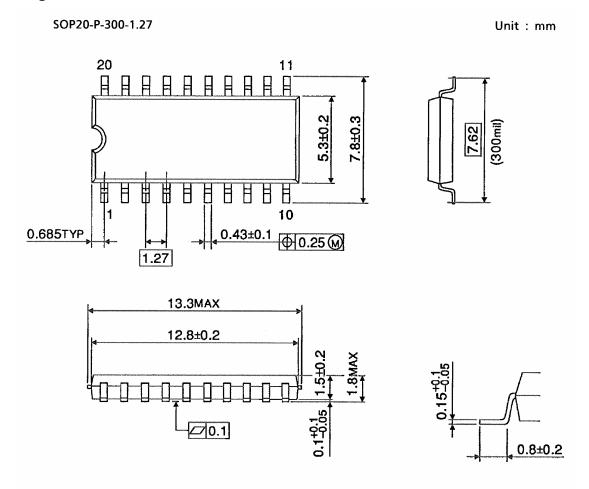
Package Dimensions



Weight: 0.22 g (typ.)



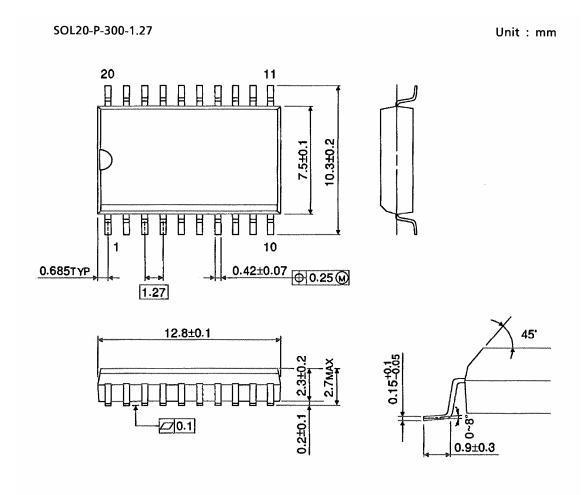
Package Dimensions



Weight: 0.22 g (typ.)



Package Dimensions (Note)



Note: This package is not available in Japan.

Weight: 0.46 g (typ.)



Note: Lead (Pb)-Free Packages

DIP20-P-300-2.54A SOP20-P-300-1.27A

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Handbook" etc. 021023_A

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